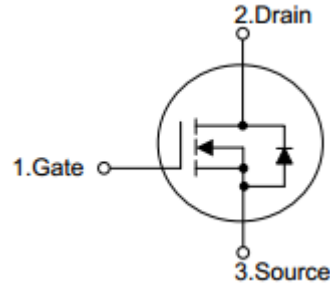


## POWER MOSFET

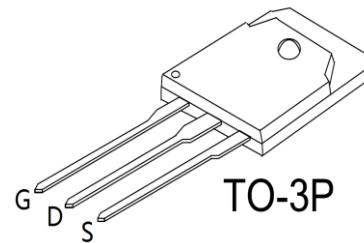
### Features

- 500V,24A N-Channel MOSFET
- $R_{DS(on)(typ.)}=0.18\ \Omega$  @  $V_{GS}=10V$
- High ruggedness
- Fast switching
- 100% avalanche tested
- Exceptional dv/dt capability



### Applications

- Electric Welding
- Computer Power
- LCD Power
- Switching application
- Motor drive



### Absolute Maximum Ratings

Symbol	Parameter	Value	Units
$V_{DSS}$	Drain-Source Voltage	500	V
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$I_D$	Continuous Drain Current( $T_C=25^\circ C$ )	24	A
	Continuous Drain Current( $T_C=100^\circ C$ )	19	A
$I_{DM}$	Pulsed Drain Current(Note 1 )	96	A
EAS	Single Pulsed Avalanche Energy(Note 2)	1100	mJ
$P_D$	Maximum Power Dissipation ( $T_C=25^\circ C$ )	290	W
$T_J$	Maximum Junction Temperature	150	$^\circ C$
$T_{STG}$	Storage Temperature Range	-55 to +150	$^\circ C$

#### Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature

2.Starting  $T_J=25^\circ C$ ,  $L=3.4mH$ ,  $R_G=25\ \Omega$ ,  $I_D=24A$ ,  $V_{GS}=10V$

## Thermal data

Symbol	Parameter	Max.	Units
$R_{th\ J-C}$	Thermal Resistance, Junction to case	0.43	°C/ W
$R_{th\ J-A}$	Thermal Resistance, Junction to air	40	°C/ W

## Electrical Characteristics (TC=25°C unless otherwise noted)

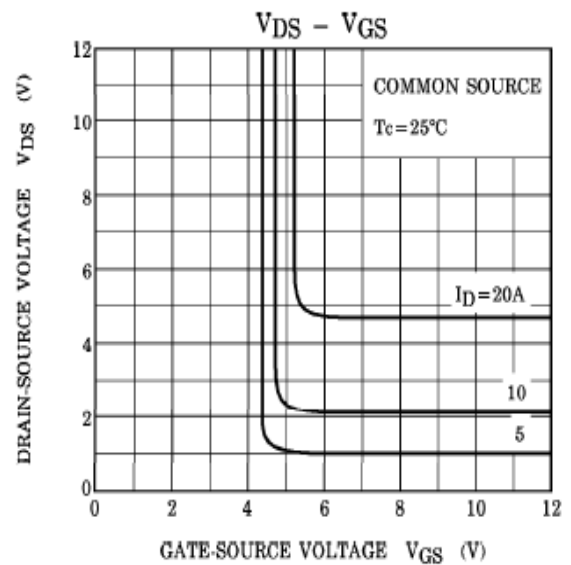
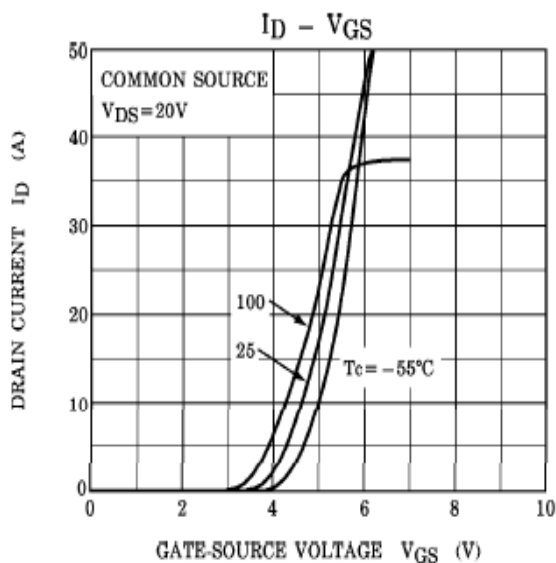
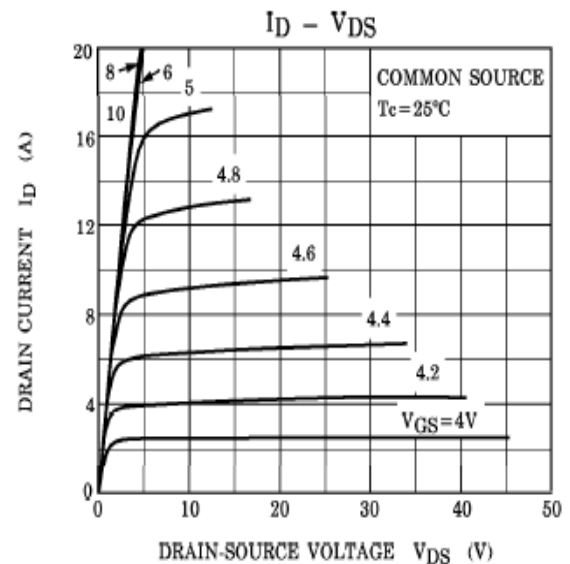
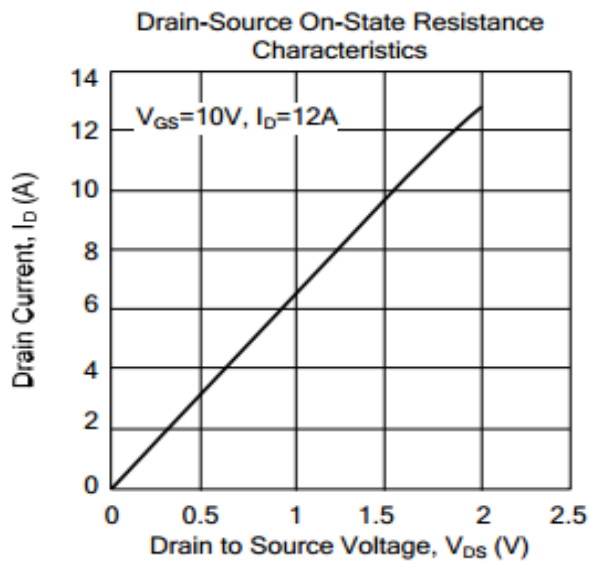
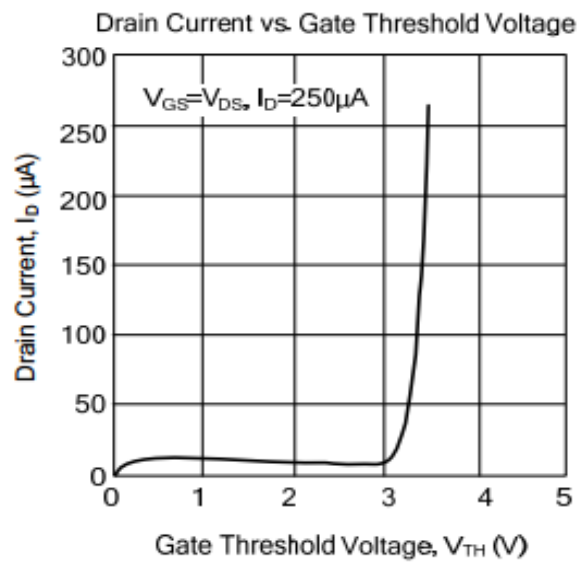
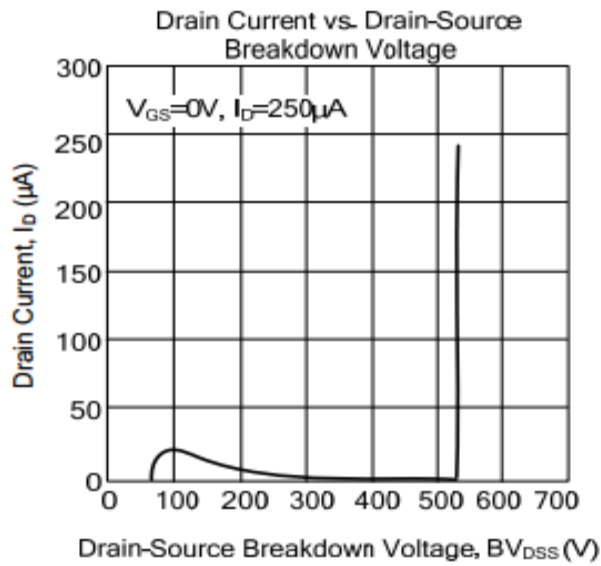
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	500			V
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS}=500V, V_{GS}=0V$			50	$\mu A$
$I_{GSS}$	Gate Leakage Current, Forward	$V_{GS}=25V, V_{DS}=0V$			100	nA
	Gate Leakage Current, Reverse	$V_{GS}=-25V, V_{DS}=0V$			-100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\mu A$	2	3	4	V
$R_{DS(on)}$	Collector-Emitter Saturation Voltage	$V_{GS}=10V, I_D=12A$		0.15	0.18	m $\Omega$
gfs	Forward Transconductance	$V_{DS}=10V, I_D=10A$	4.0	14		S
$Q_g$	Total Gate Charge	$V_{DS}=400V$ $V_{GS}=10V$ $I_D=24A$		90	120	nC
$Q_{gs}$	Gate-Source Charge			23		nC
$Q_{gd}$	Gate-Drain Charge			52		nC
$t_{d(on)}$	Turn-on Delay Time	$V_{DD}=250V, R_L=20\Omega$ $V_{GEN}=10V$ $I_D=24A$ $R_G=25\Omega$	-	80	170-	ns
$t_r$	Turn-on Rise Time		-	250	500	ns
$t_{d(off)}$	Turn-off Delay Time		-	200	400	ns
$t_f$	Turn-off Fall Time		-	155	320	ns
$C_{iss}$	Input Capacitance	$V_{DS}=25V$ $V_{GS}=0V$ $f=1MHz$	-	3500	4500	pF
$C_{oss}$	Output Capacitance		-	520	670	pF
$C_{rss}$	Reverse Transfer Capacitance		-	55	70	pF

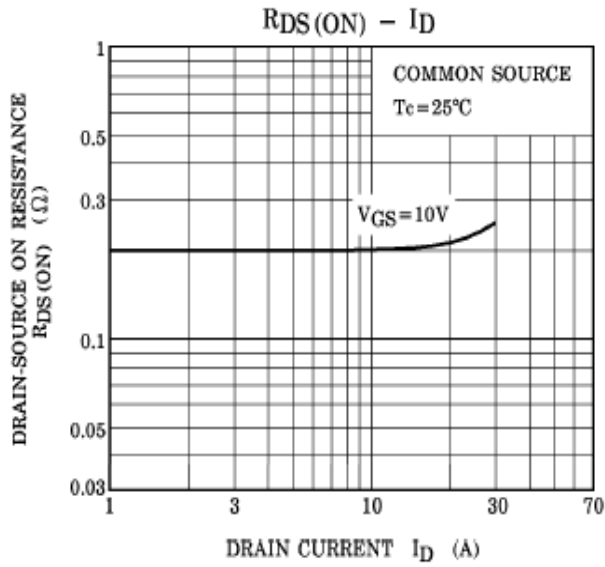
## Source-Drain Ratings and Characteristics (TC=25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$V_{SD}$	Forward On Voltage	$V_{GS}=0V, I_{SD}=20A$	-	-	1.4	V
$I_S$	Continuous Diode Forward Current				24	A
$t_{rr}$	Reverse Recovery Time	$I_{SD}=60A$ $dI_F/dt=100A/\mu s$	-	250		ns
$Q_{rr}$	Reverse Recovery Charge		-	1.1		$\mu C$

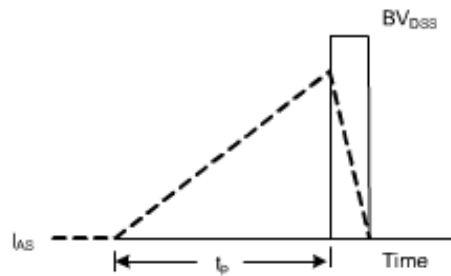
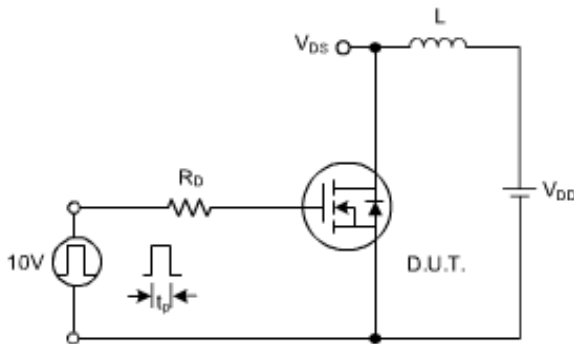


## Typical Characteristics





### Avalanche test circuits and waveforms



### Gate charge test circuits and waveforms

